

# Welcome

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# Using S-parameters for behavioral interconnect modeling

*Asian IBIS Summit*

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# Agenda

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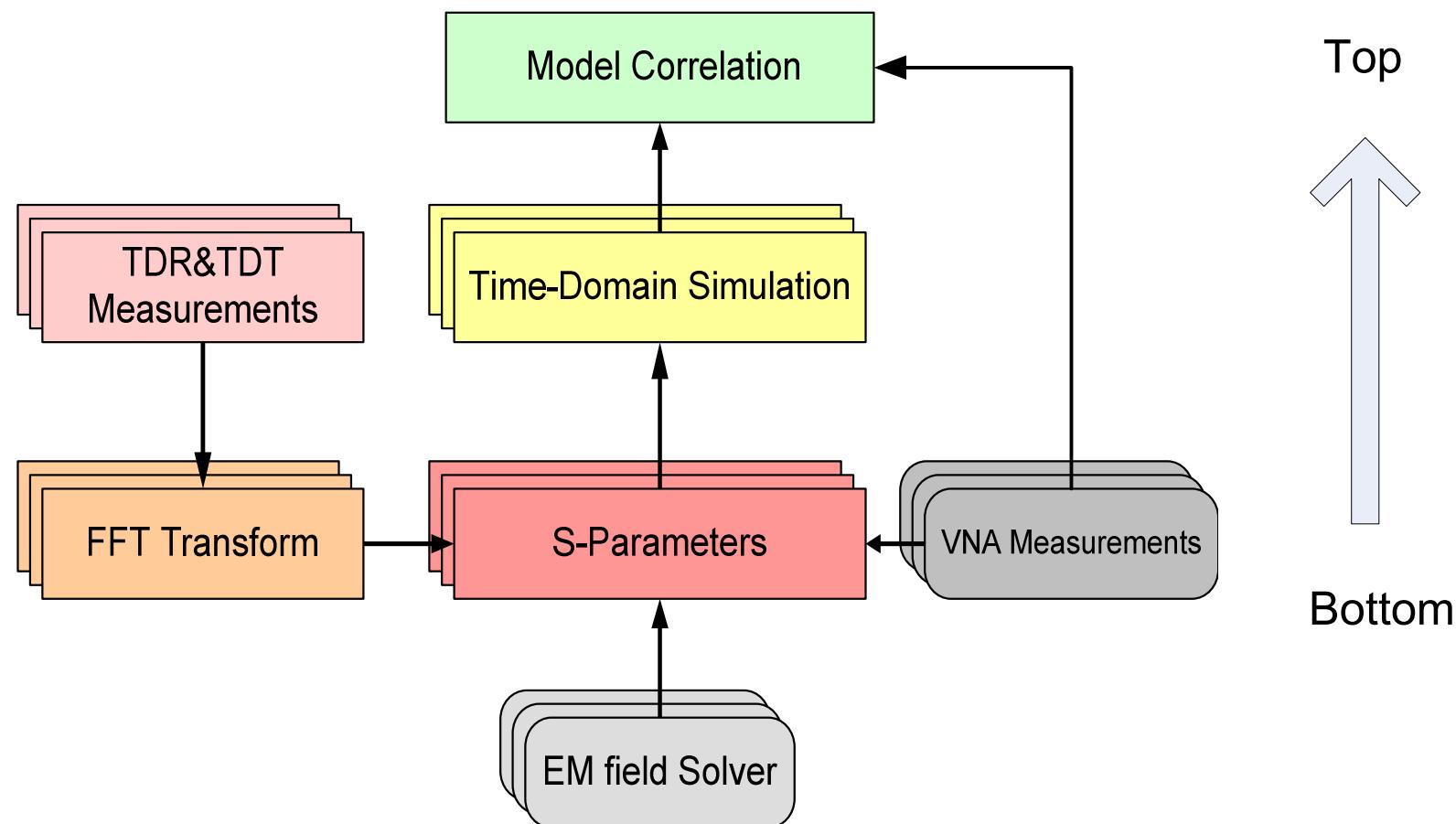
- ❖ Using S-parameters for high-Speed digital design
- ❖ Describing passive interconnects in ICM
- ❖ ICM&IBIS
- ❖ A solution for package modeling using S-parameters
- ❖ Summary

# Using S-parameters for high-Speed Digital Design

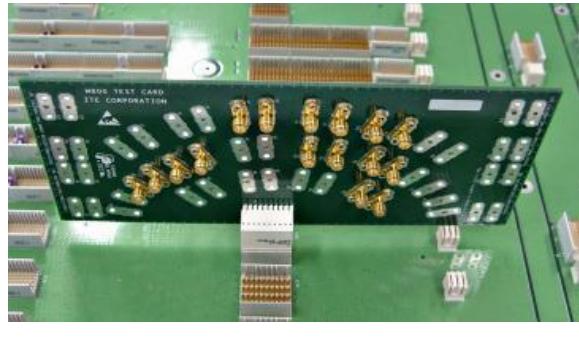
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- ❖ The signal integrity simulation of high-speed digital design requires that the interconnect modeling must be valid over a wide bandwidth.
- ❖ S-parameters can be generated by 3D EM field solver or by VNA and TDR/TDT measurements.
- ❖ S-parameters can be used to generate distributed models for transmission line and vias.
- ❖ S-parameters model can be easily correlated with VNA measurements.
- ❖ Circuit simulators can run both S-parameters and RLGC models together in time-domain.

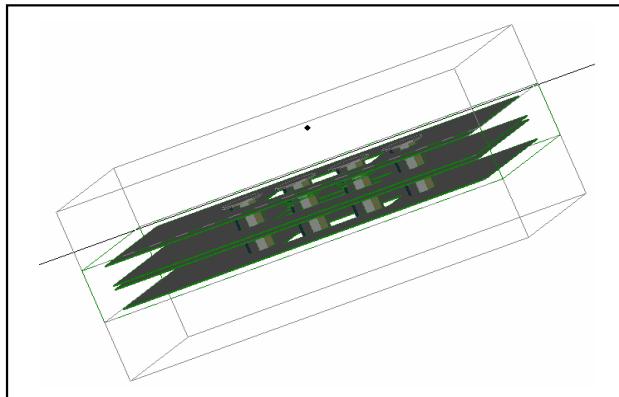
# S-parameters Extraction and Correlation



# Measurement and 3D EM Solver Modeling



Measurement setup



3D EM Solver Modeling

S-Parameter

! FILE NAME

! DATE 10/20/05 22:27

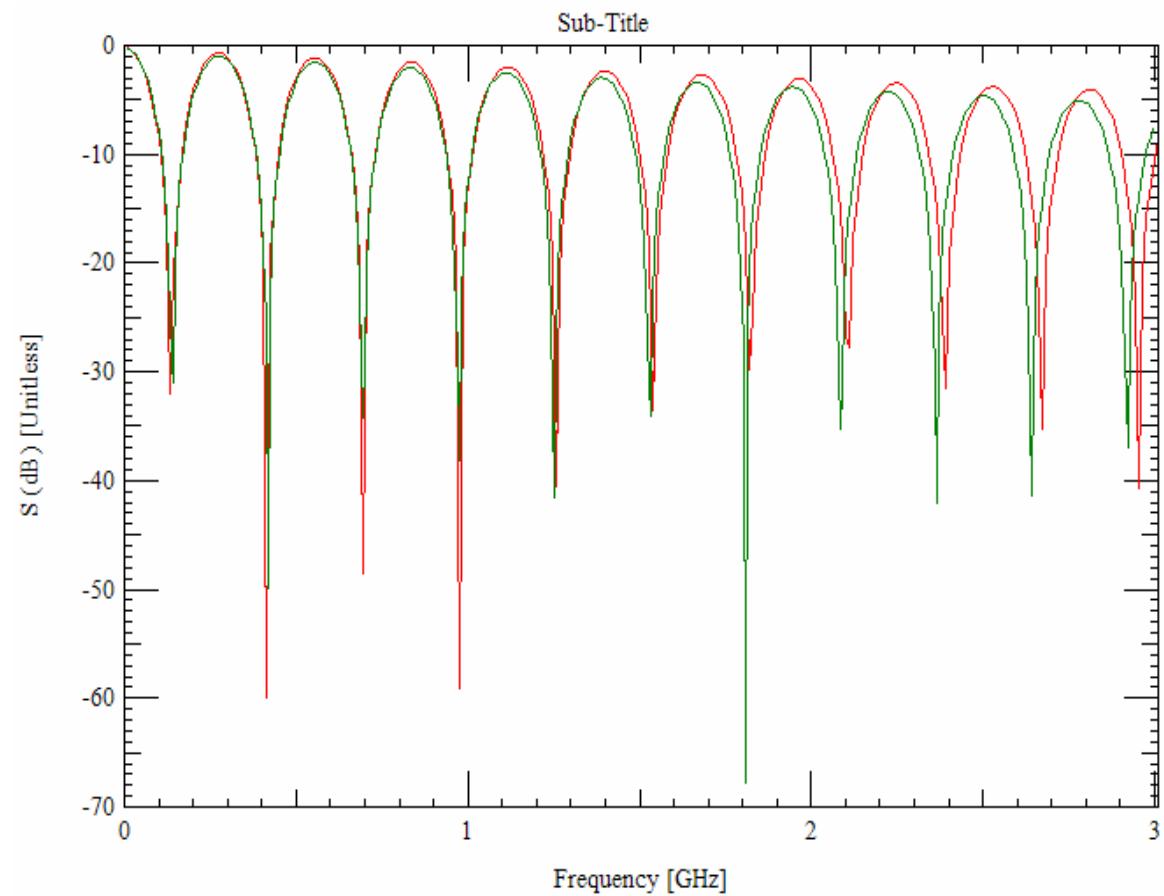
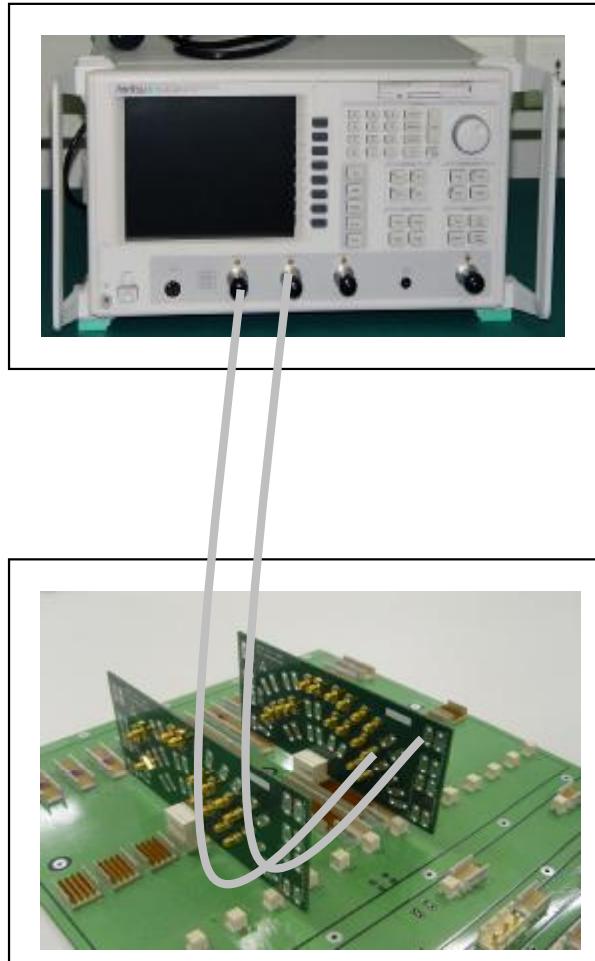
! CORRECTED DATA

# GHz S MA R 50.00

```
0.010000000 3.217487E-02 25.539 1.433922E-02 73.163 7.022051E-04 -164.797 9.721752E-01 -14.501
1.437112E-02 73.522 8.342298E-02 21.247 9.721735E-01 -14.643 1.031352E-03 152.923
6.869677E-04 -166.566 9.750083E-01 -14.799 3.180707E-02 24.806 1.426077E-02 73.110
9.757603E-01 -14.762 1.043164E-03 148.597 1.442420E-02 73.191 3.261170E-02 27.190
0.019987500 4.338055E-02 24.741 2.759167E-02 60.757 1.264493E-03 172.773 9.619784E-01 -28.320
2.753260E-02 60.598 5.663544E-02 -7.471 9.629115E-01 -28.078 8.262120E-04 130.485
1.252529E-03 171.672 9.652648E-01 -28.414 4.342042E-02 20.989 2.762920E-02 60.190
9.660442E-01 -28.600 8.369133E-04 130.697 2.751868E-02 59.706 4.591656E-02 22.958
0.029975000 5.279364E-02 19.352 3.940318E-02 47.550 1.777378E-03 145.369 9.554404E-01 -42.013
3.933148E-02 47.604 3.671105E-02 -9.347 9.577851E-01 -41.765 7.441007E-04 136.632
1.751164E-03 143.245 9.584093E-01 -42.077 5.350023E-02 13.120 3.941780E-02 46.306
9.575923E-01 -42.330 7.423362E-04 133.941 3.934892E-02 46.433 5.596628E-02 14.271
0.039962500 6.059968E-02 11.269 4.905304E-02 34.608 2.323297E-03 117.191 9.492754E-01 -55.661
4.906615E-02 34.594 3.431321E-02 15.544 9.519293E-01 -55.371 1.174888E-03 136.972
2.295646E-03 114.989 9.529339E-01 -55.758 6.189575E-02 3.980 4.901626E-02 33.024
9.517830E-01 -55.968 1.161010E-03 136.920 4.896336E-02 33.055 6.299231E-02 3.407
0.049950000 6.662585E-02 1.555 5.628981E-02 21.659 2.841726E-03 90.468 9.434645E-01 -69.209
5.633547E-02 21.883 5.111281E-02 22.288 9.453543E-01 -68.928 1.940923E-03 116.840
2.788556E-03 88.049 9.454238E-01 -69.373 6.795117E-02 -5.423 5.627455E-02 19.599
9.449649E-01 -69.579 1.899390E-03 117.875 5.611407E-02 19.671 6.618402E-02 -7.747
0.059937500 7.025610E-02 -9.871 6.094978E-02 8.924 3.319784E-03 63.903 9.380775E-01 -82.793
6.093212E-02 8.964 6.989614E-02 11.224 9.395743E-01 -82.342 2.770354E-03 88.655
3.227467E-03 61.858 9.384965E-01 -82.888 7.212381E-02 -15.124 6.077348E-02 6.385
9.384112E-01 -83.188 2.774367E-03 89.391 6.085816E-02 6.319 6.634015E-02 -18.404
0.069925000 7.160252E-02 -22.097 6.273439E-02 -3.632 3.720456E-03 37.930 9.326985E-01 -96.370
6.272058E-02 -3.522 8.357295E-02 -6.331 9.355087E-01 -95.783 3.570472E-03 57.951
3.599259E-03 36.141 9.323274E-01 -96.278 7.376438E-02 -24.634 6.278425E-02 -6.705
9.336231E-01 -96.646 3.602008E-03 58.589 6.281382E-02 -6.657 6.448640E-02 -28.081
0.079912500 7.081175E-02 -34.685 6.182219E-02 -16.100 4.040125E-03 12.437 9.270003E-01 -109.843
6.178188E-02 -15.966 8.959131E-02 -26.534 9.309905E-01 -109.271 4.262746E-03 27.041
3.903036E-03 11.300 9.269238E-01 -109.574 7.376363E-02 -34.289 6.182057E-02 -19.660
9.282665E-01 -110.146 4.314952E-03 26.898 6.182886E-02 -19.667 6.259895E-02 -35.944
```

S-Parameter touchstone file

# Lab Correlation for S-parameters

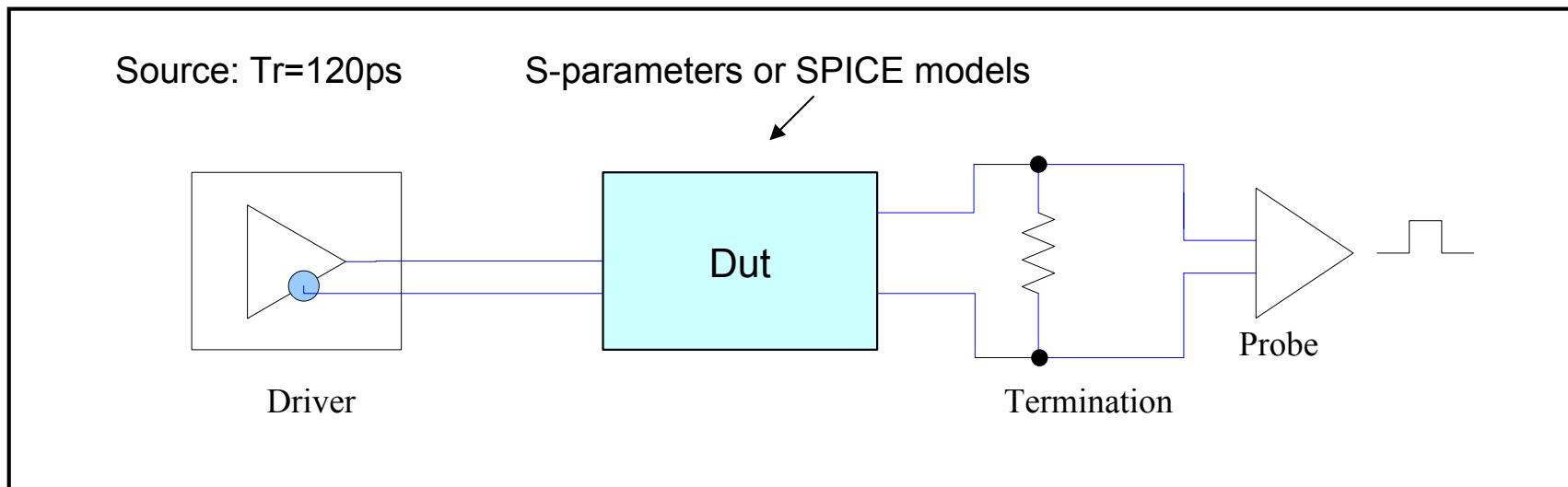


S21 data comparison between VNA measurement and Simulation



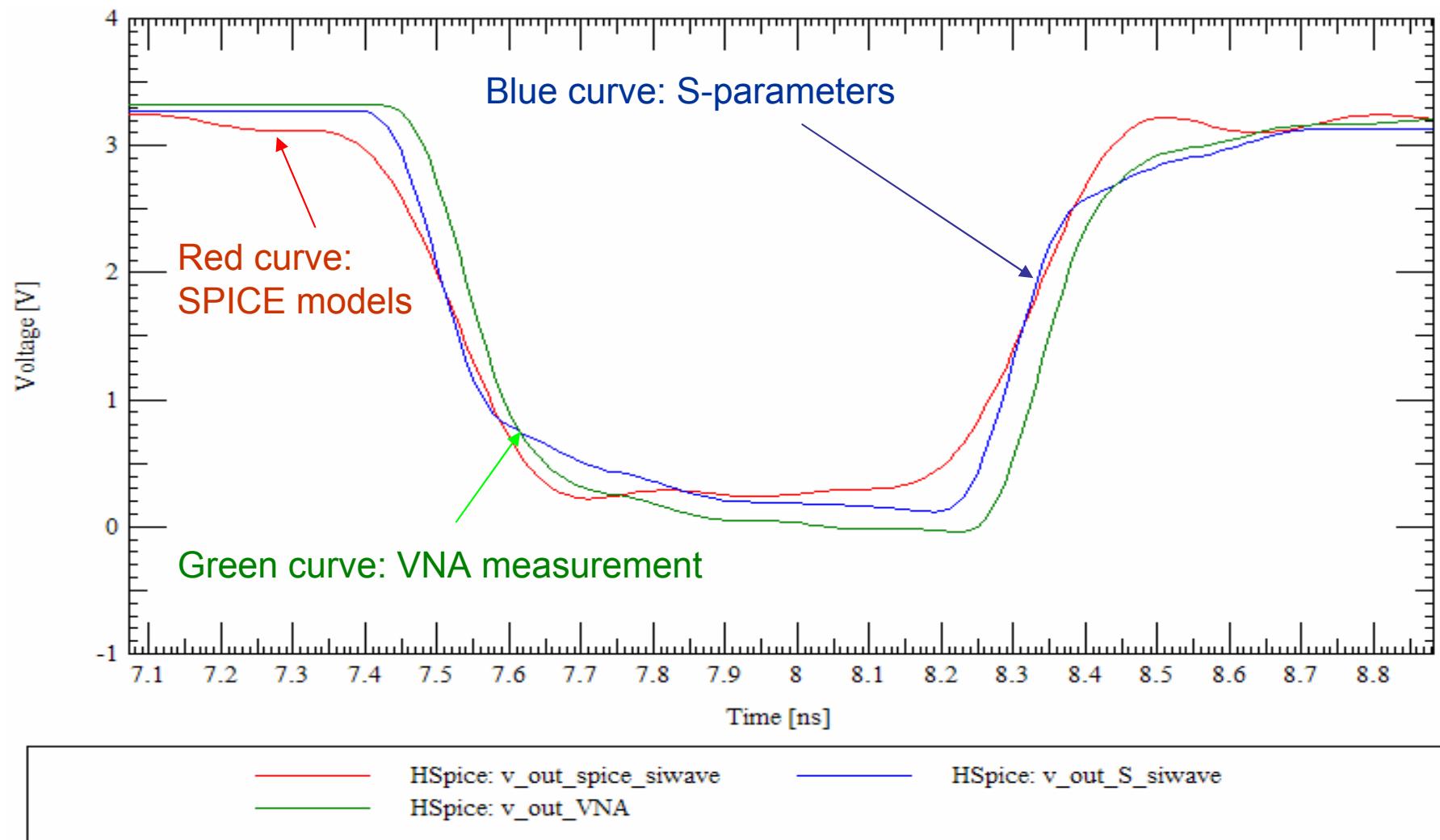
# Simulation using S-parameters and SPICE models

- 1 Simulation using S-parameters extracted by EM field solver
- 2 Simulation using RLGC models
- 3 Correlate with laboratory measurements



Measurement versus Simulation

# Lab Correlation for S-parameters and SPICE models



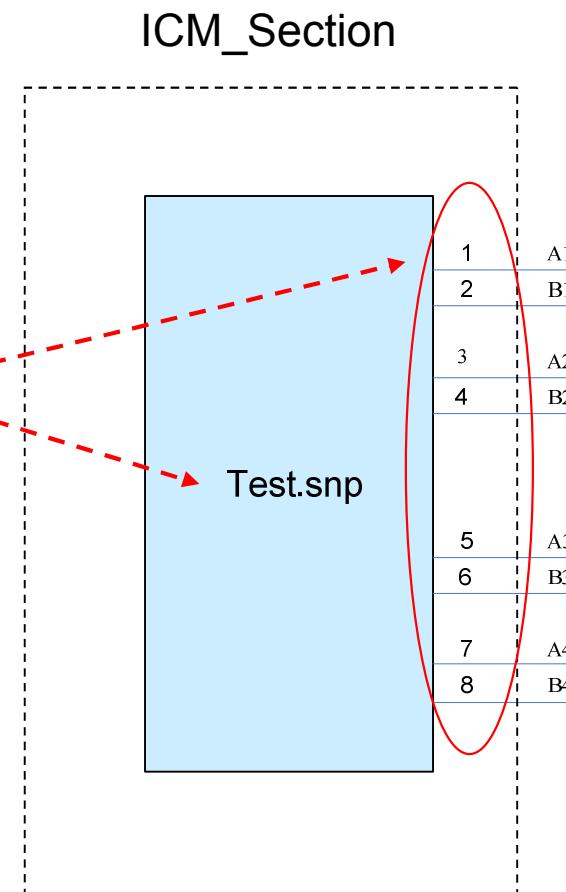
# ICM&IBIS

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- ❖ IBIS Interconnect Modeling Specification (ICM) permits model authors to describe passive interconnects in a tool-neutral, behavioral, human-readable way similar to IBIS.
- ❖ ICM supports S-parameter data.
- ❖ ICM supports RLGC frequency-dependent matrices.
- ❖ ICM does not include connections between IBIS [Model], IBIS [Pin] and ICM ports today.

# Describing passive interconnects in ICM

```
[Begin_ICM_Section] S_para_example
[Derivation Method] Lumped
[ICM S-parameter]
File_name test.snp
Port_assignment
|Port Node
1 A1
2 B1
3 A2
4 B2
5 A3
6 B3
7 A4
8 B4
[End ICM Section] S_para_example
```



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# How do we link ICM to IBIS?

# [ External Circuit ] in IBIS ver4.2

- ❖ Accepting SPICE, VHDL-AMS, Verilog-AMS, VHDL-A(MS) or Verilog-A(MS) as arguments.

Component Die	Package	Pins/balls
[External Circuit]	[External Circuit]	
A	A_mypcr-+--a+-vccal	vcc-+--10-----@0@--o 10 Vcc
	A_mypur-+--b+-vcca2	
D_drive-- >----+--A_mysig-+--c+-int_ioa	io1-+--1-----@0@--o 1 Buffer A	
D_enable-  /   A_mypdr-+--d+-vssa1		
D_receive--<  + A_mygcr-+--e+-vssa2	gnd-+--pad_11-+---@0@--o 11 GND	
	Die_Interconnect	ICM Package
[External Circuit]		Interconnect
B		
	A_mypur-+--f+-vccb1	Self Ad
D_drive-- >----A_mysig-+--g+-int_ob	o2-+--pad_2a-+---@0@--o 2 justing	
/ A_mypdr-+--h+-vssb1	Buffer	
A_mycnt		
	Analog Buffer Control	
		pad_2b-+---@0@--+

New syntax required  
for arbitrary ports

Language→Touchstone ?

A proposal for IBIS package modeling using S-parameters



# Linking ICM to IBIS

## [Node Declarations]

|Die pads or pin names  
A1, A2, A3, A4  
pad1, pad2, pad3, pad4  
[End Node Declarations]

IBIS

## [ICM Pin Map] sample\_ext

Pin\_order Row\_ordered  
Num\_of\_columns = 4  
Num\_of\_rows = 1  
Pin\_list  
|Pin Name  
A1 D1  
A2 D2  
A3 D3  
A4 D3

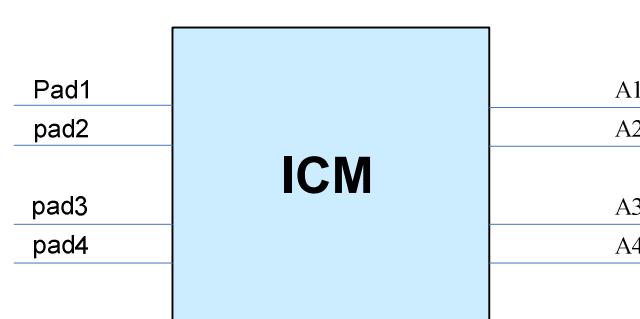
ICM

## [ICM Pin Map] sample\_int

Pin\_order Row\_ordered  
Num\_of\_columns = 4  
Num\_of\_rows = 1  
Pin\_list  
|Pin Name  
pad1 D1  
pad2 D2  
pad3 D3  
pad4 D4

ICM

To Buffer

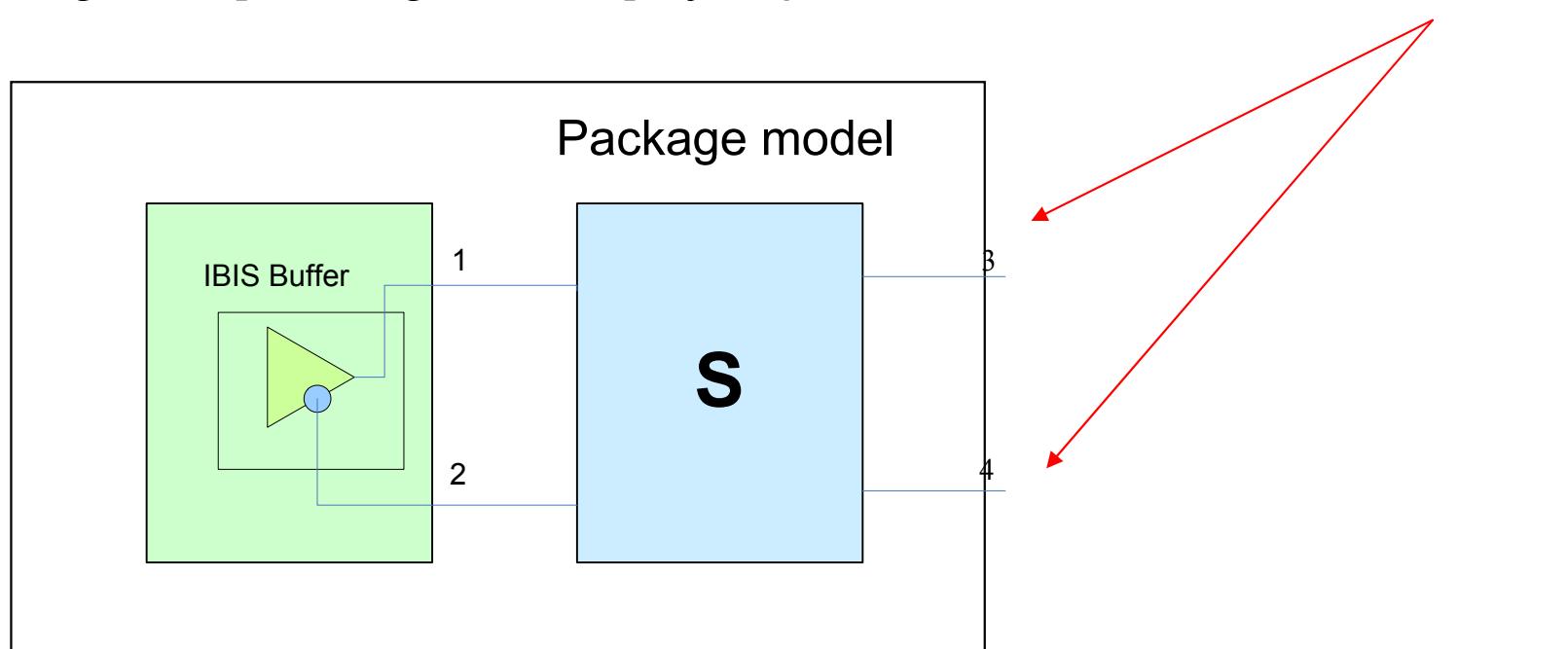


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## How do we use S-parameters for package modeling now?

# Package modeling using S-parameters

- ❖ Many EDA tools support S-parameter simulation.
- ❖ Using subcircuits to describe S-parameter model.
- ❖ Replacing IBIS [Package Model] by S-parameter model.



# A solution for package modeling using S-parameters

```
(../../Pkg_models/s_para_pkg.dml"
(PackagedDevice
(s_para_pkg
(ESpice ".subckt s_para_pkg 1 2 3 4
Xs_para_pkg_4Port 1 3 2 4

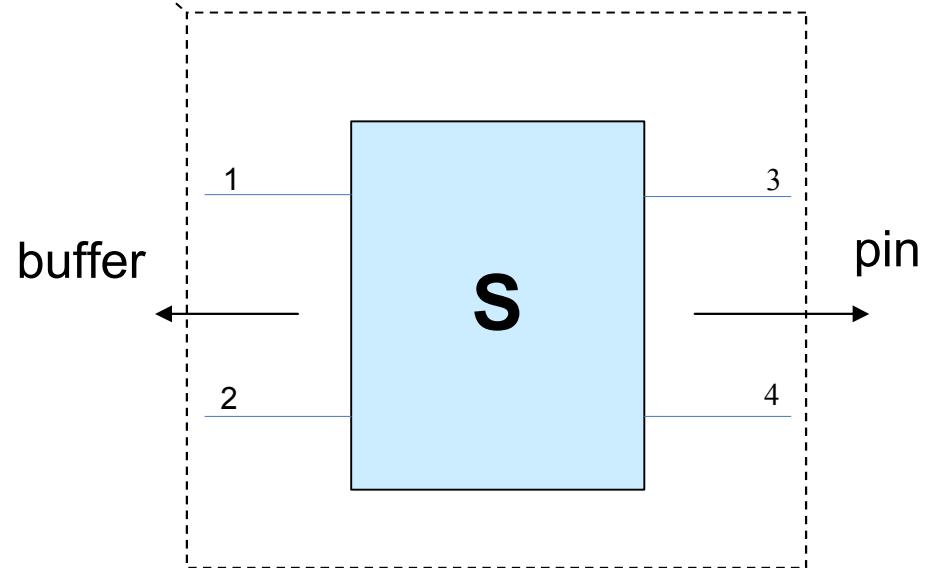
.subckt s_para_pkg_4Port_Data 1 2 3 4
S1 1 2 3 4 algorithm=default
DATAPOINTS SPARAM
R=50.000000
DATAUNIT=HZ
FREQUENCY=0.000000e+000
.

.END SPARAM
.ends s_para_pkg_4Port_Data

.ends s_para_pkg_4Port" )
(PinConnections
.

(NumberOfPorts 4 )
(SubType SPARAM ) ))
(LibraryVersion 136.2 ) )
```

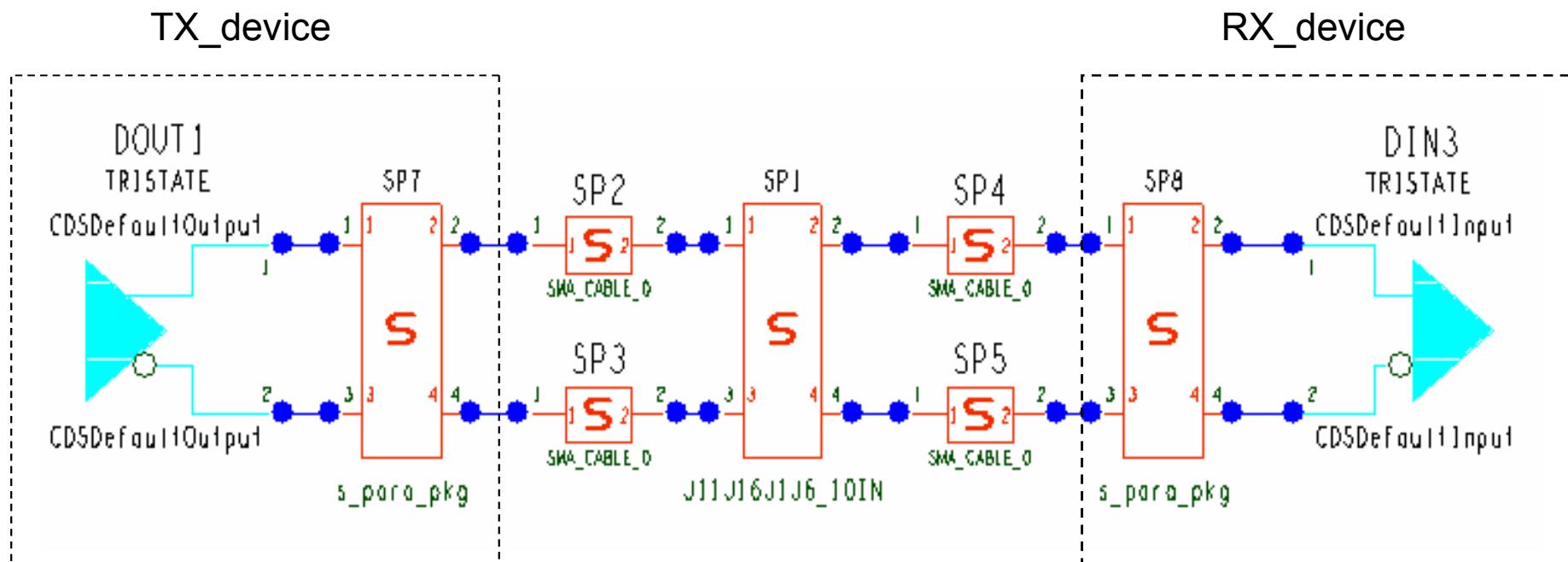
Package modeling using DML model



S-parameters can be added to  
Cadence DML file.

# A solution for package modeling using S-parameters

- ❖ IBIS IO buffer modeling
- ❖ S-parameter package models of transceiver
- ❖ Connecting buffer models to package models in topology.



# Summary

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- ❖ S parameter features:
  - Behavioral modeling method compatible with IBIS style.
  - Much shorter simulation time compared with RLC connector models..
- ❖ Benefit IBIS ICM with S parameter:
  - “One model, one platform, one simulator” for both active and passive components.
  - Pave the way for behavioral, yet accurate enough IBIS simulation for very high speed circuit well beyond gigahertz.

# References

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- ❖ Michael Mirmak, "IBIS & ICM Interfacing: A New Proposal".
- ❖ IBIS Interconnect Modeling Specification (ICM) Version 1.0 (Sept. 12, 2003)
- ❖ I/O Buffer Information Specification (IBIS) Version 4.2 (June 2, 2006)



**Global Connections Universal Solutions**

**Thank You**

<http://www.zte.com.cn>